

SiC MOSFET I3M12045K4

N-Channel Enhancement Mode

Features

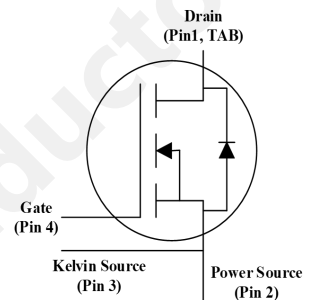
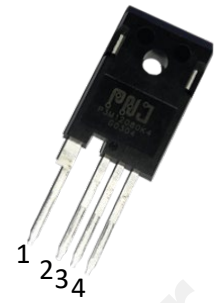
- Qualified to AEC-Q101
- High Blocking Voltage with Low On-Resistance
- High-Frequency Operation
- Ultra-Small Q_{gd}
- 100% UIS tested

Benefits

- Improve System Efficiency
- Increase Power Density
- Reduce Heat Sink Requirements
- Reduction of System Cost

Applications

- Solar Inverters
- EV Battery Chargers
- High Voltage DC/DC Converters
- Switch Mode Power Supplies



TO-247-4

Drain	1
Power Source	2
Kelvin Source	3
Gate	4



Order Information

Part Number	Package	Marking
I3M12045K4	TO-247-4	I3M12045K4

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1. Maximum Ratings

At $T_J = 25^\circ\text{C}$, unless specified otherwise

Parameter	Symbol	Value	Unit	Test Conditions
Drain - Source Voltage	V_{DSmax}	1200	V	$V_{GS} = 0V$ $I_D = 100\mu A$
Gate - Source Voltage (dynamic)	V_{GSmax}	-8 / +22	V	Duty cycle $\leq 1\%$
Gate - Source Voltage(static) turn-on gate voltage turn-off gate voltage	$V_{GS,on}$ $V_{GS,off}$	+15 / +18 -3	V	Static
Continuous Drain Current	I_D	45	A	$V_{GS} = 18V$ $T_C = 25^\circ\text{C}$
		32		$V_{GS} = 18V$ $T_C = 100^\circ\text{C}$
		41		$V_{GS} = 15V$ $T_C = 25^\circ\text{C}$
		29		$V_{GS} = 15V$ $T_C = 100^\circ\text{C}$
Pulsed Drain Current	$I_{D(pulse)}$	120	A	$PW \leq 10\mu s$, Duty cycle $\leq 1\%$
Power Dissipation	P_D	220	W	
Operating Junction	T_J	-55 To +175	$^\circ\text{C}$	
Storage Temperature	T_{stg}	-55 To +175	$^\circ\text{C}$	
Solder Temperature	T_L	260	$^\circ\text{C}$	
Mounting Torque	M_d	1 8.8	Nm lbf-in	M3 or 6-32 screw

2. Electrical Characteristics

At $T_J = 25^\circ\text{C}$, unless specified otherwise

Parameter	Symbol	Value			Unit	Test Conditions
		Min.	Typ.	Max.		
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	1200	/	/	V	$V_{GS} = 0V$ $I_D = 0.8mA$
Gate Threshold Voltage	$V_{GS(th)}$	1.8	2.5	/	V	$V_{DS} = V_{GS}$ $I_D = 10mA$ $T_J = 25^\circ\text{C}$
		/	1.8	/	V	$V_{DS} = V_{GS}$ $I_D = 10mA$ $T_J = 175^\circ\text{C}$
Reverse Bias Drain Current	I_{DSS}	/	1	100	μA	$V_{GS} = 0V$ $V_{DS} = 1200V$
Gate-Source Leakage Current	I_{GSS}	/	1	250	nA	$V_{GS} = -5 \sim 18V$ $V_{DS} = 0V$
Drain-Source On-State Resistance	$R_{DS(on)}$	/	45	59	m Ω	$V_{GS} = 18V$ $I_D = 20A$ $T_J = 25^\circ\text{C}$
		/	76	/		$V_{GS} = 18V$ $I_D = 20A$ $T_J = 175^\circ\text{C}$
		/	60	/		$V_{GS} = 15V$ $I_D = 20A$ $T_J = 25^\circ\text{C}$
		/	84	/		$V_{GS} = 15V$ $I_D = 20A$ $T_J = 175^\circ\text{C}$
Transconductance	g_{fs}	/	12	/	S	$V_{DS} = 20V$ $I_{DS} = 20A$ $T_J = 25^\circ\text{C}$
		/	10	/		$V_{DS} = 20V$ $I_{DS} = 20A$ $T_J = 175^\circ\text{C}$

Parameter	Symbol	Value			Unit	Test Conditions	
		Min.	Typ.	Max.			
Input Capacitance	C _{iss}	/	2070	/	pF	V _{GS} = 0V V _{DS} = 800V f= 1MHz V _{AC} = 25mV	
Output Capacitance	C _{Oss}	/	96	/			
Reverse Transfer Capacitance	C _{rss}	/	11	/			
Coss Stored Energy	E _{Oss}	/	37	/	μJ		
Turn-on Energy	E _{on}	/	130	/	μJ	V _{DS} = 800V V _{GS} = -4/15V I _D = 20A R _G = 1Ω	
Turn-off Energy	E _{off}	/	45	/			
Turn-On Delay Time	T _{d(on)}	/	22.7	/	ns		
Rise Time	T _r	/	12.5	/			
Turn-Off Delay Time	T _{d(off)}	/	25.6	/			
Fall Time	T _f	/	8	/			
Turn-on Energy	E _{on}	/	116	/	μJ		V _{DS} = 800V V _{GS} = -4/18V I _D = 30A R _G = 1Ω
Turn-off Energy	E _{off}	/	40	/			
Turn-On Delay Time	T _{d(on)}	/	20.8	/	ns		
Rise Time	T _r	/	11	/			
Turn-Off Delay Time	T _{d(off)}	/	27.2	/			
Fall Time	T _f	/	8	/			
Internal Gate Resistance	R _{G(int)}	/	2.0	/	Ω	f= 1MHz V _{AC} = 25mV	

Parameter	Symbol	Value			Unit	Test Conditions
		Min.	Typ.	Max.		
Gate to Source Charge	Q_{gs}	/	22	/	nC	$V_{DS} = 800V$ $I_{DS} = 20A$ $V_{GS} = -3/15V$ $I_G = 20mA$
Gate to Drain Charge	Q_{gd}	/	14	/		
Total Gate Charge	Q_g	/	54	/		
Gate to Source Charge	Q_{gs}	/	24	/	nC	$V_{DS} = 800V$ $I_{DS} = 20A$ $V_{GS} = -4/18V$ $I_G = 20mA$
Gate to Drain Charge	Q_{gd}	/	15	/		
Total Gate Charge	Q_g	/	66	/		

3. Reverse Diode Characteristics

At $T_J = 25^\circ\text{C}$, unless specified otherwise

Parameter	Symbol	Value		Unit	Test Conditions
		Typ.	Max.		
Diode Forward Voltage	V_{SD}	5.5	/	V	$V_{GS} = -3\text{V}$ $I_{SD} = 10\text{A}$ $T_J = 25^\circ\text{C}$
		5.3	/	V	$V_{GS} = -3\text{V}$ $I_{SD} = 10\text{A}$ $T_J = 175^\circ\text{C}$
Continuous Diode Forward Current	I_S	/	38	A	$V_{GS} = -3\text{V}$
Reverse Recover Time	t_{rr}	32.5	/	ns	$V_{GS} = -4/15\text{V}$ $I_{SD} = 20\text{A}$ $V_R = 800\text{V}$ $dI/dt = 2800\text{A}/\mu\text{s}$ $T_J = 25^\circ\text{C}$
Reverse Recovery Charge	Q_{rr}	159	/	nC	
Peak Reverse Recovery Current	I_{rrm}	19.2	/	A	
Reverse Recover Time	t_{rr}	28.5	/	ns	$V_{GS} = -4/18\text{V}$ $I_{SD} = 20\text{A}$ $V_R = 800\text{V}$ $dI/dt = 2900\text{A}/\mu\text{s}$ $T_J = 25^\circ\text{C}$
Reverse Recovery Charge	Q_{rr}	155	/	nC	
Peak Reverse Recovery Current	I_{rrm}	15.6	/	A	

4. Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance from Junction to Case	$R_{\theta JC}$	0.68	$^\circ\text{C}/\text{W}$

5. Typical Performance

At $T_J = 25^\circ\text{C}$, unless specified otherwise

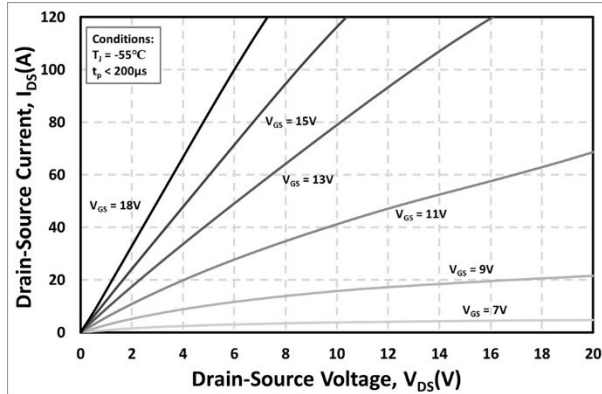


Figure 1. Output Characteristics $T_J = -55^\circ\text{C}$

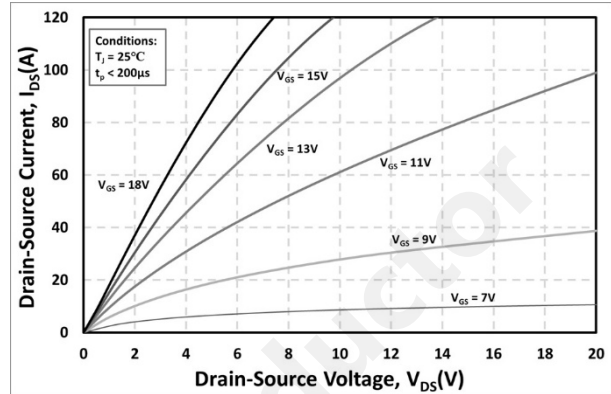


Figure 2. Output Characteristics $T_J = 25^\circ\text{C}$

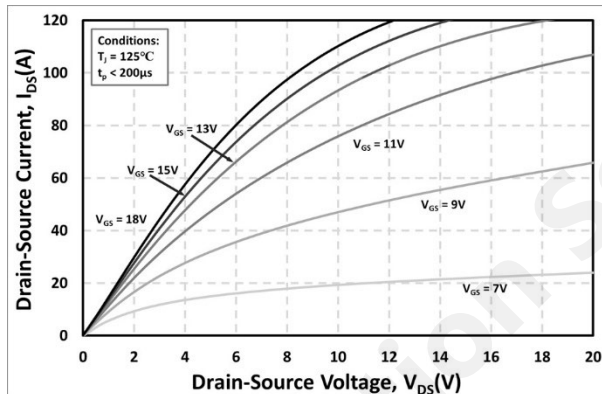


Figure 3. Output Characteristics $T_J = 125^\circ\text{C}$

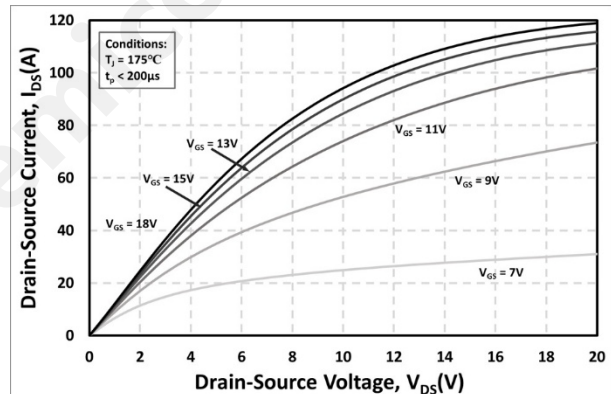


Figure 4. Output Characteristics $T_J = 175^\circ\text{C}$

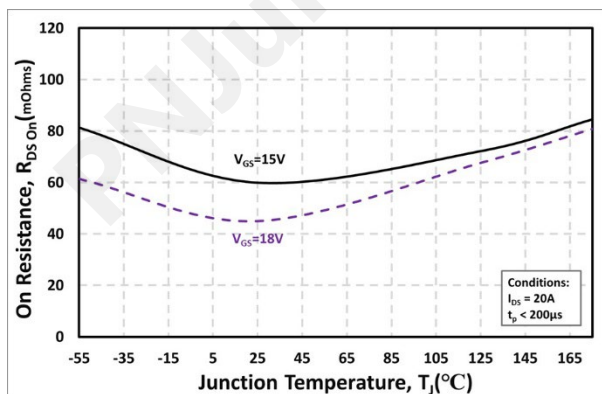


Figure 5. Normalized On-Resistance vs. Temperature

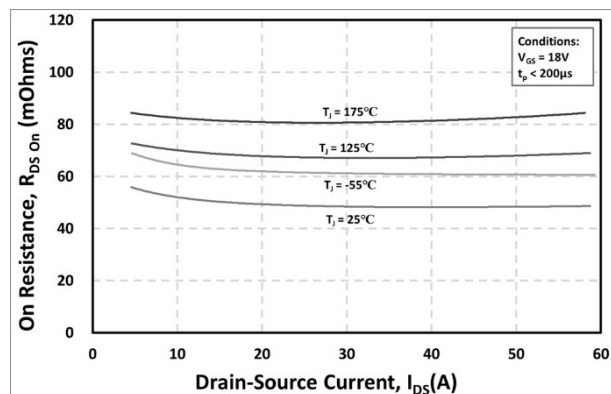


Figure 6. On-Resistance vs. Drain Current Various Temperatures

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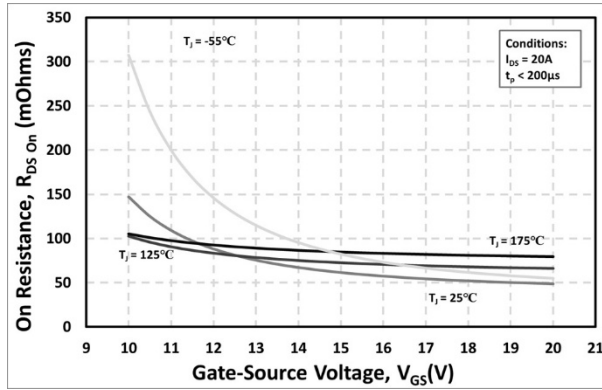


Figure 7. On-Resistance vs. Gate-Source Voltage

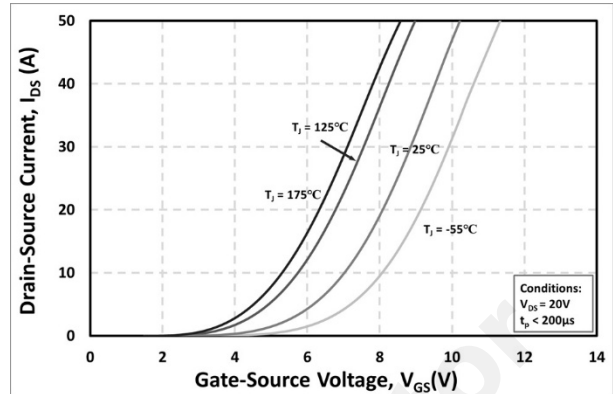


Figure 8. Transfer Characteristic for Various Junction Temperatures

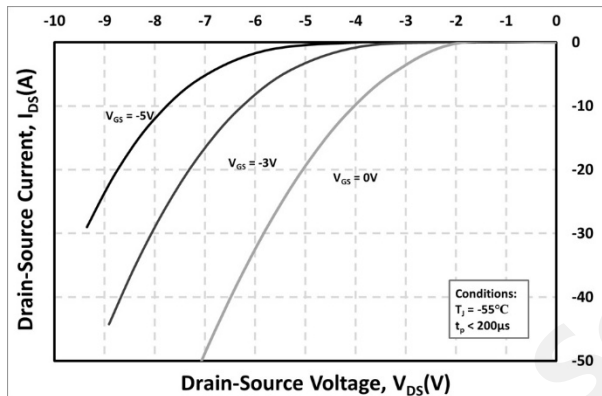


Figure 9. Body Diode Characteristic at -55°C

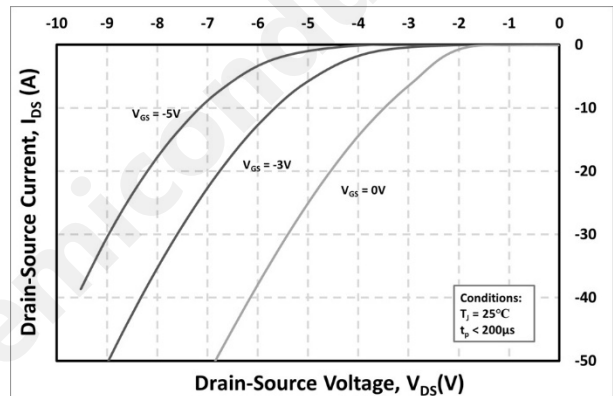


Figure 10. Body Diode Characteristic at 25°C

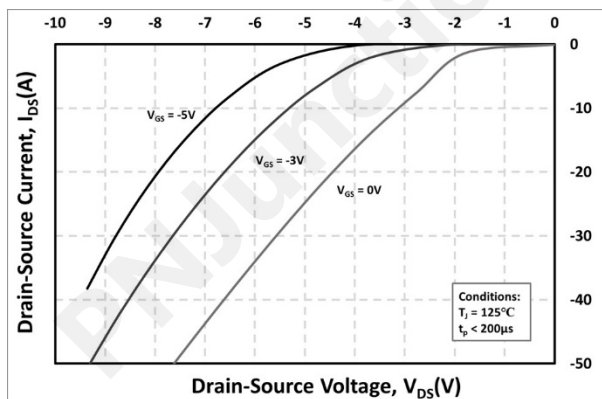


Figure 11. Body Diode Characteristic at 125°C

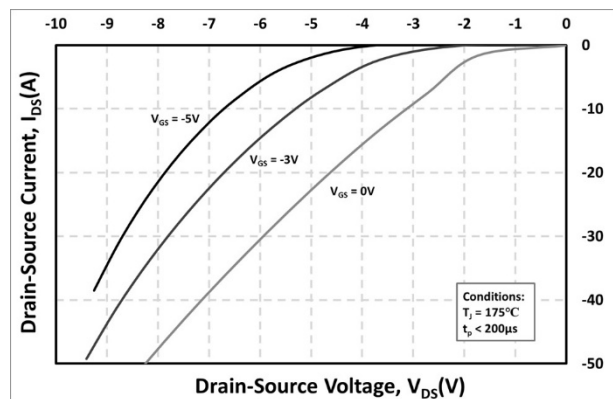


Figure 12. Body Diode Characteristic at 175°C

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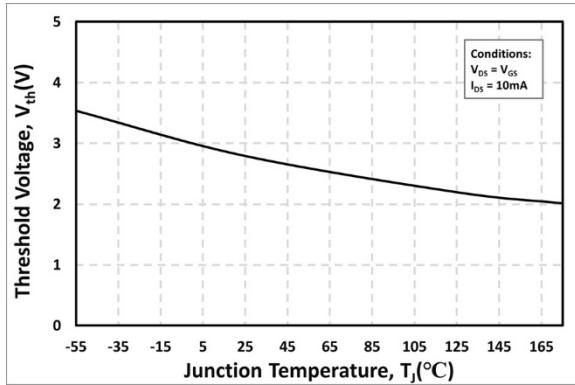


Figure 13. Threshold Voltage vs. Temperature

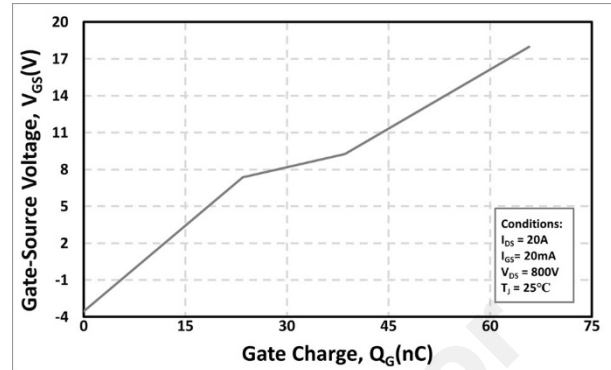


Figure 14. Gate Charge Characteristics

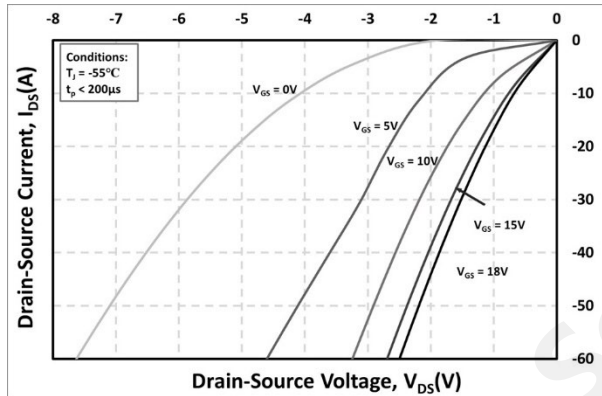


Figure 15. 3rd Quadrant Characteristic at -55°C

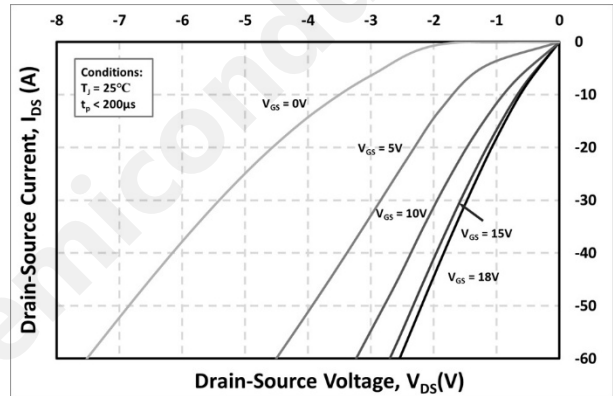


Figure 16. 3rd Quadrant Characteristic at 25°C

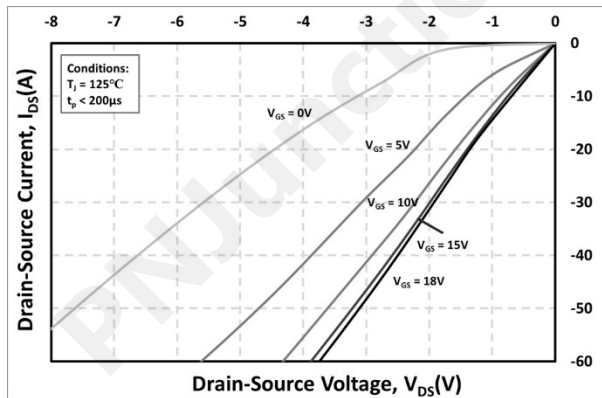


Figure 17. 3rd Quadrant Characteristic at 125°C

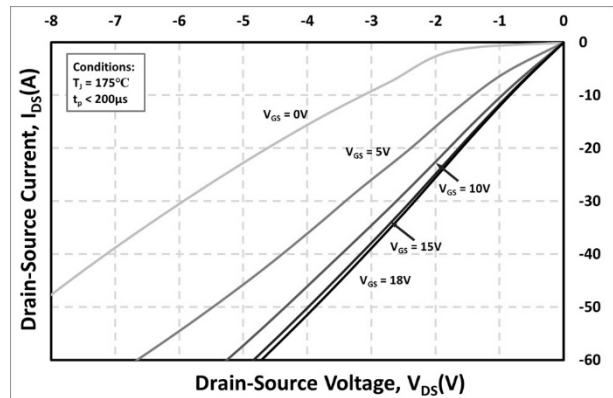


Figure 18. 3rd Quadrant Characteristic at 175°C

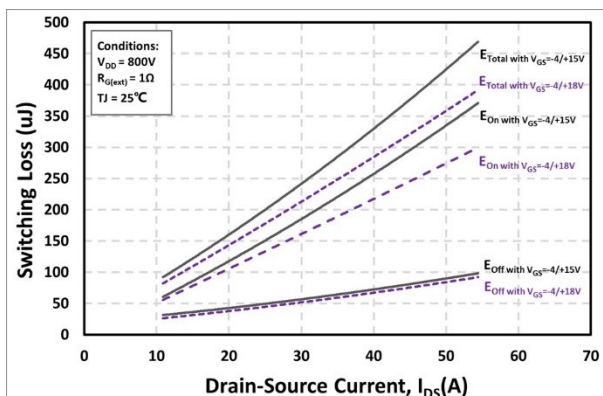


Figure 19. Clamped Inductive Switching Energy vs. Drain Current ($V_{DS} = 800V$)

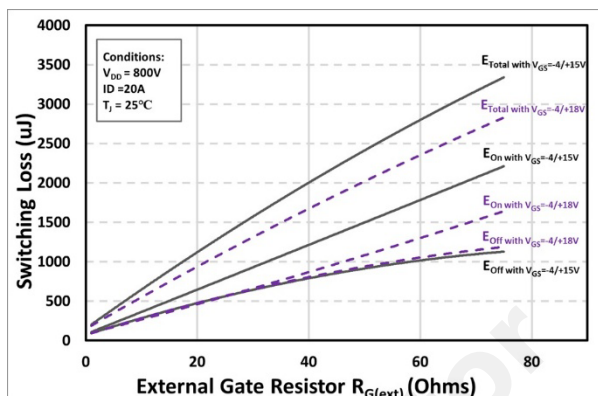


Figure 20. Clamped Inductive Switching Energy vs. $R_{G(ext)}$

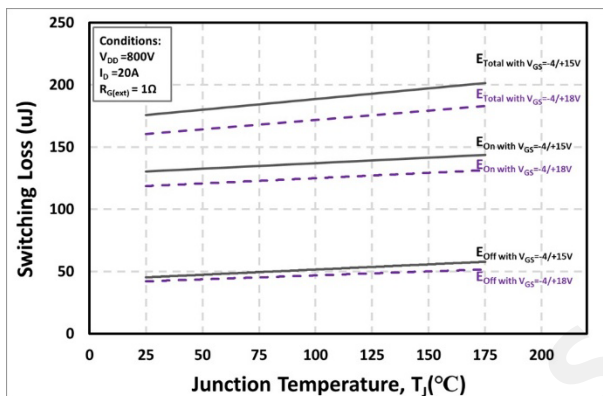


Figure 21. Clamped Inductive Switching Energy vs. Temperature

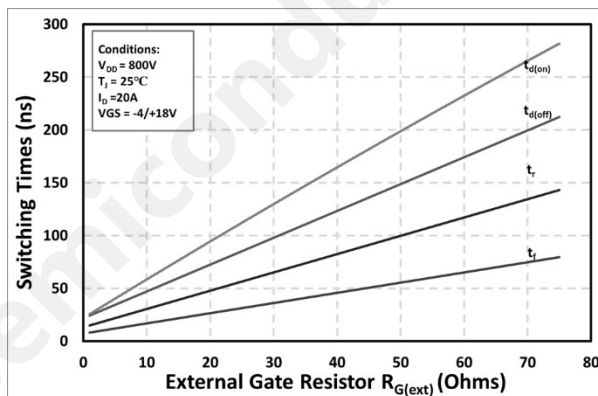


Figure 22. Switching Times vs. $R_{G(ext)}$

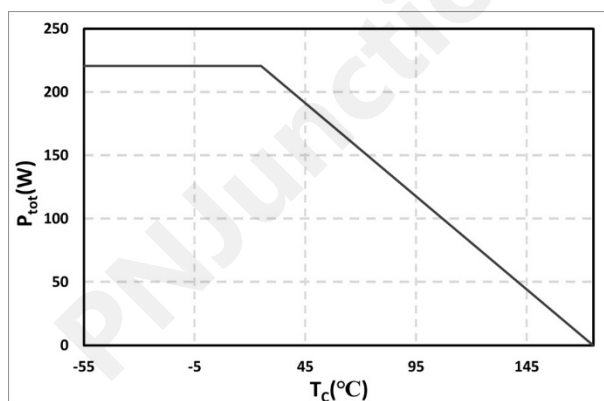


Figure 23. Maximum Power Dissipation Derating vs. Case Temperature

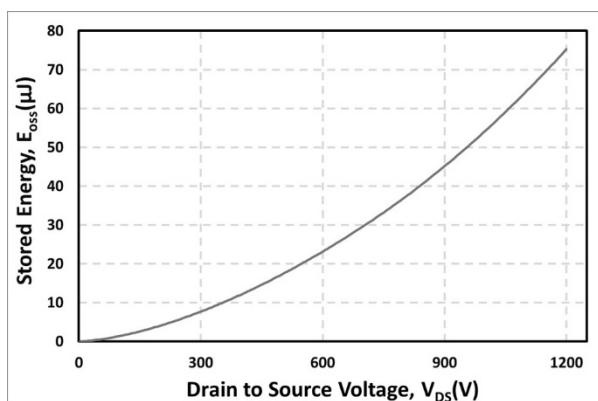


Figure 24. Output Capacitor Stored Energy

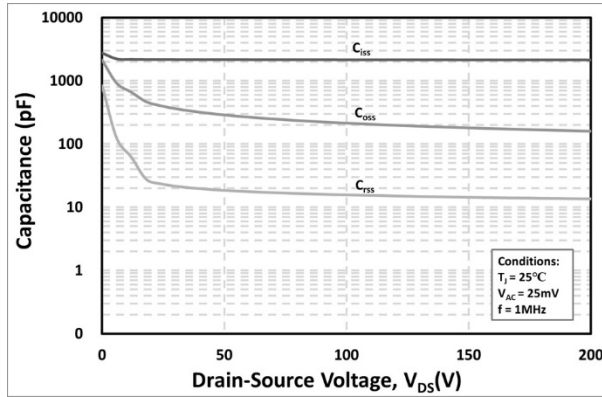


Figure 25. Capacitances vs. Drain-Source Voltage (0 - 200V)

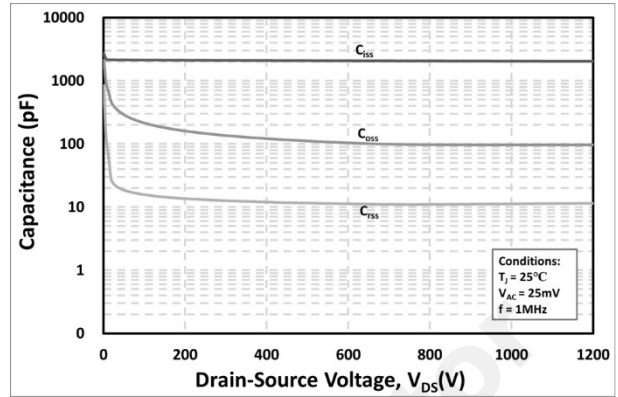


Figure 26. Capacitances vs. Drain-Source Voltage (0 - 1000V)

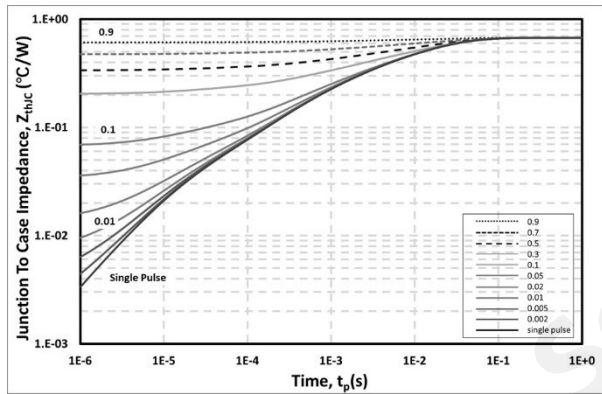


Figure 27. Transient Thermal Impedance (Junction - Case)

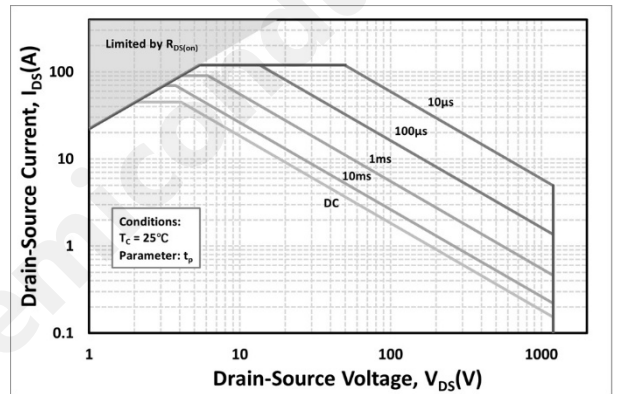


Figure 28. Safe Operating Area

6. Definitions

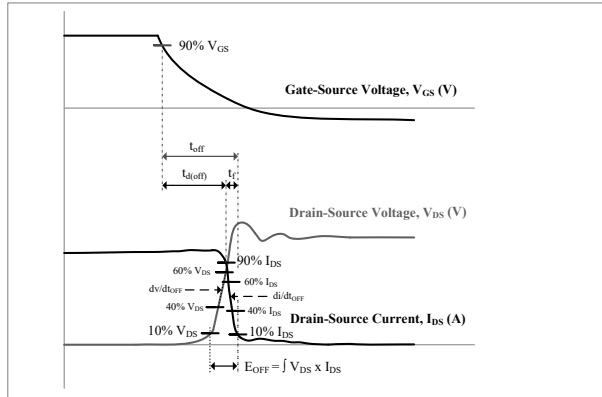


Figure 29. Turn-off Transient Definitions

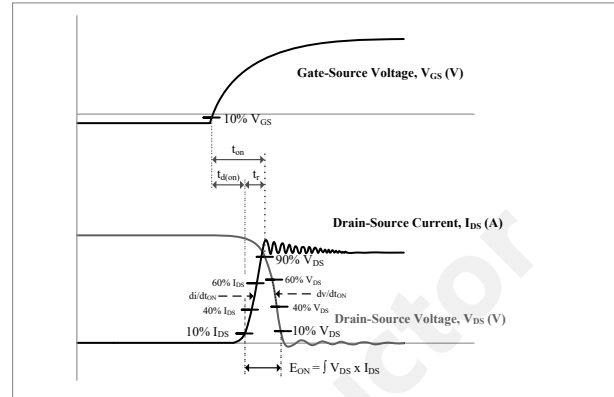


Figure 30. Turn-on Transient Definitions

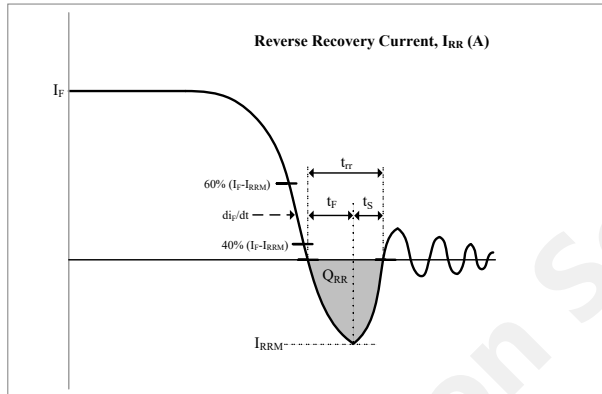


Figure 31. Reverse Recovery Definitions

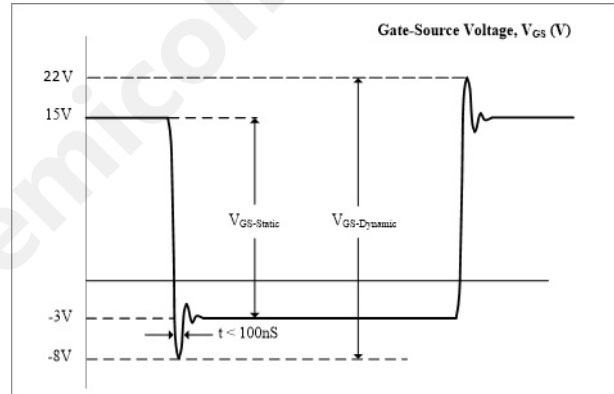
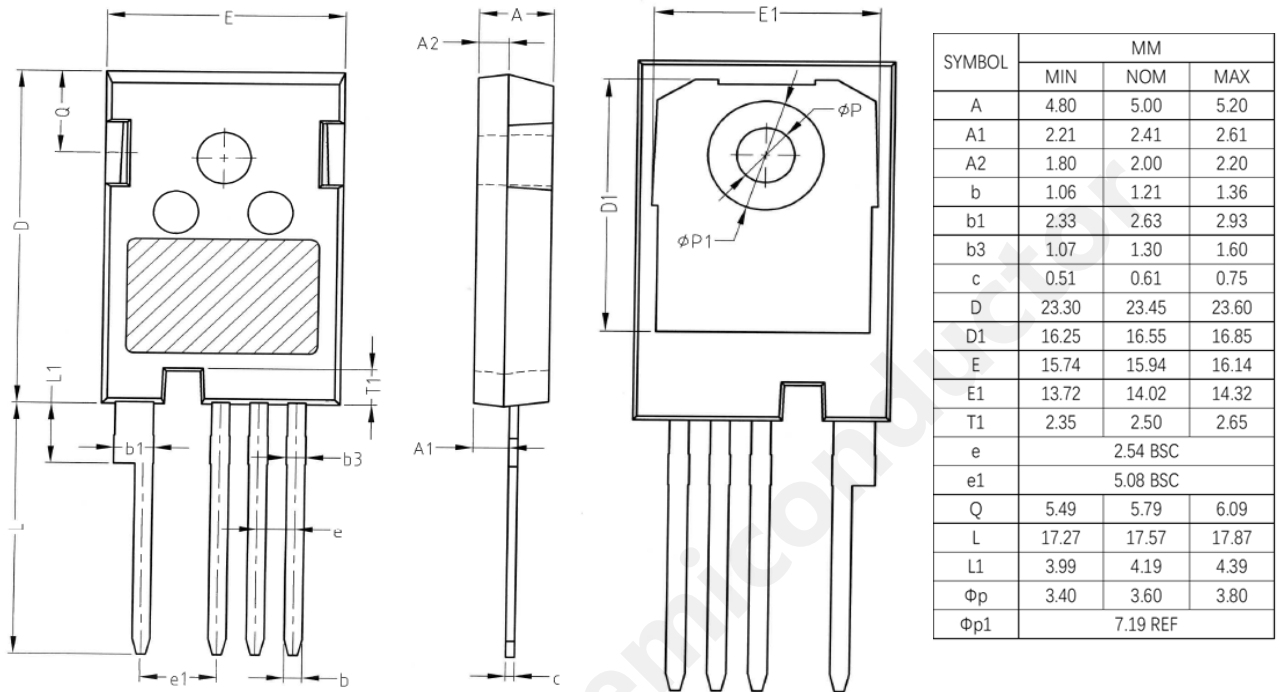


Figure 32. V_GS Transient Definitions

7. Package Outlines



Drawing and Dimensions

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